Search Notes		
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Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/712,594	FUJIYOSHI ET	AL.
Examiner	Art Unit	
W. David Coleman	2823	

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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST 2.0.1 Applicant claims a comparative circuit with memory for a electron beam exposure apparatus	6/28/2005	WDC
Text search only	6/28/2005	WDC
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